

International standard spring-loaded test probes for In-circuit test

During in-circuit tests(ICT) all components on the PCB are measured. So defective components are detected and can be replaced accordingly.

In-circuit test probe pins are used for testing the electrical performance of in-circuit components on PCB and the connection between circuit networks. It could measure the components, such as resistors, capacitors, inductors, and perform functional tests of optocouplers, transformers, operational amplifiers, power supply modules and integrated circuits.

SF-P11 series test probe pin

SF-P111 series test probe pin

SF-P100 series test probe pin

Suzhou Shengteng Electronic Co., Ltd is the leading manufacturer of test probe pins in China. In 1984 we set up the first factory in Cixi city, we have been specialized in pogo pins, Bare PCB test probes, In-circuit test probes, high current test probes, and semiconductor test probes for more than 30 years. With the advantages of advanced equipment and strict inspection process, our products sell well in Europe, North America and Southeast Asia. In the future, we will keep on working hard with the dream of the China's and the World's.

Looking forward to cooperating with you.